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	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				
	INFORMATION DISCLOSURE STATEMENT		Docket Number: 10537/331		
	Application Serial No.: To Be Assigned 39	Filing Date: Herewith	Examiner: To Be Assigned	An Unit: To Be Assigned	
	International Application No. PCT/DE2004/002473 Title: METHOD, DEVICE, AND TEST SPECIMEN FOR TESTING A PART, AND USE OF THE METHOD AND DEVICE		International Filing Date: November 9, 2004		
			Inventor(s): Joachim BAMBERG et al.		

Mail Stop PCT Commissioner for Patents P.O. Box 1450 Alexandria, Virginia 22313-1450

- 1. In accordance with the duty of disclosure under 37 C.F.R. § 1.56 and in conformance with the procedures of 37 C.F.R. §§ 1.97 and 1.98 and M.P.E.P. § 609, attorneys for Applicant(s) hereby bring the citations listed on the attached modified PTO form 1449 to the attention of the Examiner. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the citations be made of record therein and appear among the "References Cited" on any patent to issue therefrom. The filing of this Information Disclosure Statement and the enclosed PTO Form No. 1449, shall not be construed as an admission that the information cited is prior art, or is considered to be material to patentability as defined in 37 C.F.R. § 1.56(b).
- 2. A copy of each patent, publication or other information listed on the modified PTO form 1449 is enclosed, except as otherwise indicated.

Date: Jun 2, 2006

Respectfully submitted,

By:

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IAP20 Rec'd PCT/PTO 02 JUN 2006

INFORMATION DISCLOSURE STATEMENT BY APPLICANTS PTO-1449

Attorney Docket No. 10537/331	Serial No. 0./581539
Applicant(s) Joachim BAMBERG et al.	
Filing Date Herewith	Group Art Unit To Be Assigned

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT/ PUBLICATION NUMBER	PATENT/PUBLICATION DATE	NAME	CLASS	SUBCLASS	FILING DATE
	4,747,295*	May 31, 1988	Feist et al.			
	5,670,719	September 23, 1997	Madsen et al.			

^{*} Listed in International Search Report.

FOREIGN PATENT DOCUMENTS

EXAMINER'S		DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
INITIALS						YES	NO
	2002-328098*.**	November 15, 2002	JP				
	44 07 547*.**.	September 21, 1995	DE				
	7-76167*.**	March 20, 1995	JP				
	0 743 128*·**	November 20, 1996	EP				
	199 25 801*.**.	December 21, 2000	DE				
	2002-48773*.**.	February 15, 2002	JP				
	7-229878*·**	August 29. 1995	JР				
	100 15 702*****	October 18, 2001	DE				
	34 25 263**.***	January 31, 1985	DE	<u></u>			

OTHER DOCUMENTS

EXAMINER'S INITIALS	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.				
	Patent Abstracts of Japan, Vol. 2003, No. 03, May 5, 2003*				
	Patent Abstracts of Japan, Vol. 1995, No. 06, July 31, 1995				
	Patent Abstracts of Japan, Vol. 2002, No. 06, June 4, 2002				
	Patent Abstracts of Japan, Vol. 1995, No. 11, December 26, 1995*				
	International Search Report, PCT International Patent Application No. PCT/DE2004/002473, April 1, 2005 (translated).				
	Written Opinion of the International Searching Authority, PCT International Patent Application No. PCT/DE2004/002473, April 1, 2005 (translation of Supplemental Sheets provided).				

^{*} Listed in International Search Report.

EXAMINER	DATE CONSIDERED		
EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.			

^{*} Listed in International Search Report.
** English-language abstract provided.
*** Mentioned in Specification.